Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/630,948	HANG, WEI ZHAN	
Examiner	Art Unit	
Phi D. A	3637	

SEARCHED								
Class	Subclass	Date	Examiner					
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			)
		DATE	EXMR
PA see attached			
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